

Search Notes



Application/Control No.

10/774,310

Examiner

Hwei-Siu C. Payer

Applicant(s)/Patent under Reexamination

LINN ET AL.

Art Unit

3724

SEARCHED

Class	Subclass	Date	Examiner
030	158	6-20-05	Payer
	159		
	160		
	155		
	156		
	157		
	161		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
cam with (offset adj pin)	6-20-05	Payer
(cam with pin) and (30/155-161.ccls.)		
check with chuck Mah class 16-no search needed	6-20-05	Payer